

**Search Notes**

Application/Control No.

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Examiner

Alain L. Bashore

Applicant(s)/Patent under  
Reexamination

OIKAWA ET AL.

Art Unit

1762

**SEARCHED**

Class	Subclass	Date	Examiner
427	127, 128, 130, 121 132	9/18/2005	AB

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (attached)	9/18/2005	AB